

FDZ206P

P-Channel 2.5V Specified PowerTrench® BGA MOSFET

General Description

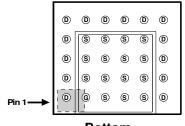
Combining Fairchild's advanced 2.5V specified PowerTrench process with state of the art BGA packaging, the FDZ206P minimizes both PCB space and $R_{\text{DS(ON)}}$. This BGA MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, high current handling capability, ultralow profile packaging, low gate charge, and low R_{DS(ON)}.

Applications

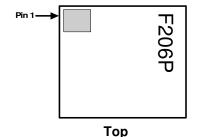
- · Battery management
- · Load switch
- · Battery protection

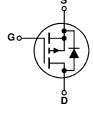
Features

- -13 A, -20 V. $R_{DS(ON)} = 9.5$ m Ω @ $V_{GS} = -4.5$ V $R_{DS(ON)} = 14.5 \text{ m}\Omega$ @ $V_{GS} = -2.5 \text{ V}$
- Occupies only 14 mm² of PCB area. Only 42% of the area of SO-8
- Ultra-thin package: less than 0.80 mm height when mounted to PCB
- 0.65 mm ball pitch
- 3.5 x 4 mm² footprint
- · High power and current handling capability









Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		-20	V
V _{GSS}	Gate-Source Voltage		±12	V
I _D	Drain Current - Continuous	(Note 1a)	-13	A
	– Pulsed		–60	
P _D	Power Dissipation (Steady State)	(Note 1a)	2.2	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	56	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction-to-Ball	(Note 1)	4.5	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	0.6	

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
206P	FDZ206P	13"	12mm	3000

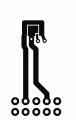
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	racteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = -250 \mu\text{A}$	-20			V
$\Delta BV_{DSS} \over \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu A$, Referenced to 25°C		-13		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			-1	μΑ
I _{GSSF}	Gate-Body Forward Leakage	$V_{GS} = -12 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
I _{GSSR}	Gate-Body Reverse Leakage	$V_{GS} = 12 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	nA
On Char	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = -250 \mu\text{A}$	-0.6	-0.9	-1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \mu A$, Referenced to 25°C		3.3		mV/°C
$R_{DS(on)}$	Static Drain–Source On–Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -13 \text{ A}$ $V_{GS} = -2.5 \text{ V}, I_D = -10.5 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_D = -13 \text{ A}, T_J = 125 ^{\circ}\text{C}$		7 10 9	9.5 14.5 13	mΩ
I _{D(on)}	On-State Drain Current	$V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$	-60			Α
g _{FS}	Forward Transconductance	$V_{DS} = -5 \text{ V}, \qquad I_{D} = -13 \text{ A}$		58		S
Dvnamio	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$		4280		pF
Coss	Output Capacitance	f = 1.0 MHz		873		pF
C _{rss}	Reverse Transfer Capacitance			400		pF
	ng Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -10 \text{ V}, \qquad I_{D} = -1 \text{ A},$		17	31	ns
t _r	Turn-On Rise Time	$V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$		11	20	ns
t _{d(off)}	Turn-Off Delay Time			115	184	ns
t _f	Turn-Off Fall Time			60	96	ns
Q _q	Total Gate Charge	$V_{DS} = -10 \text{ V}, \qquad I_{D} = -13 \text{ A},$		38	53	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = -4.5 \text{ V}$		7		nC
Q_{gd}	Gate-Drain Charge			10		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings				
I _S	Maximum Continuous Drain-Source	<u> </u>			-1.8	Α
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = -1.8 \text{ A} \text{(Note 2)}$		-0.7	-1.2	V
t _{rr}	Diode Reverse Recovery Time	$I_F = -13A$,		34		nS

Notes

1. R_{BJA} is determined with the device mounted on a 1 in² 2 oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. The thermal resistance from the junction to the circuit board side of the solder ball, R_{BJB}, is defined for reference. For R_{BJC}, the thermal reference point for the case is defined as the top surface of the copper chip carrier. R_{BJC} and R_{BJB} are guaranteed by design while R_{BJA} is determined by the user's board design.



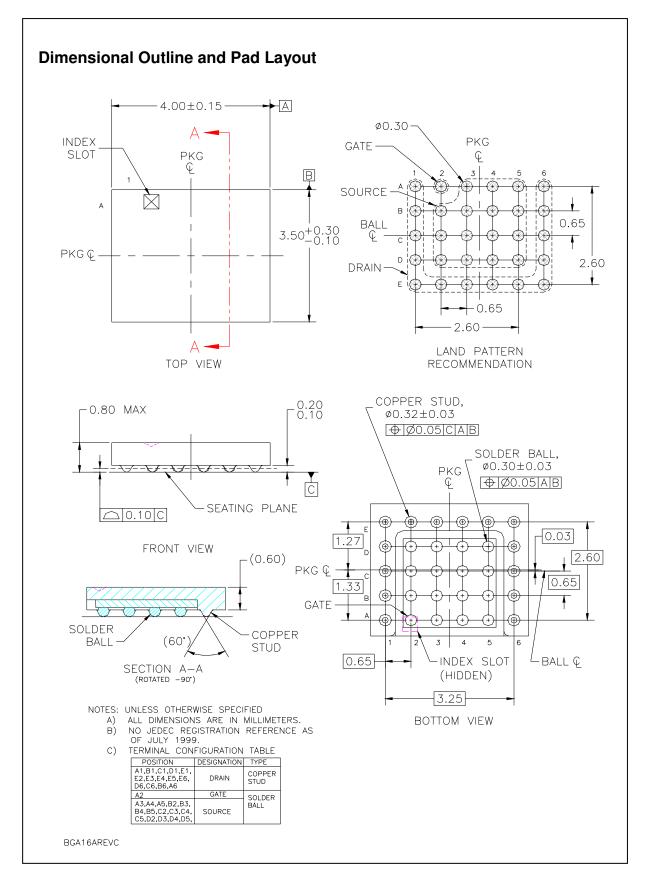
a) 56 °C/W when mounted on a 1in² pad of 2 oz copper



o) 119 °C/W when mounted on a minimum pad of 2 oz

Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%



Typical Characteristics

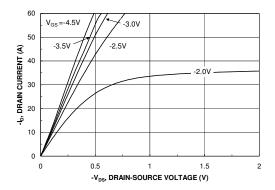


Figure 1. On-Region Characteristics.

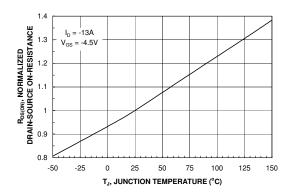


Figure 3. On-Resistance Variation with Temperature.

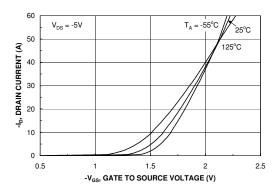


Figure 5. Transfer Characteristics.

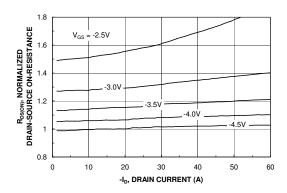


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

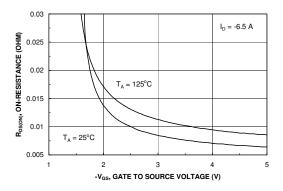


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

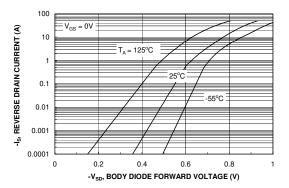
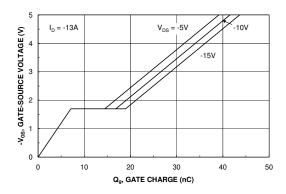


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



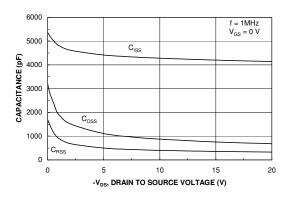


Figure 7. Gate Charge Characteristics.

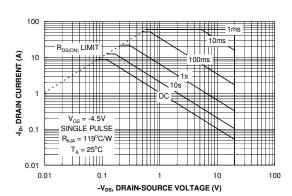


Figure 8. Capacitance Characteristics.

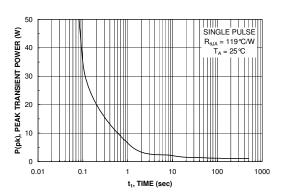


Figure 9. Maximum Safe Operating Area.



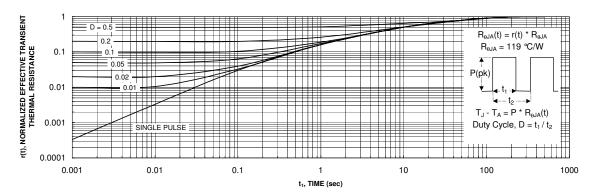


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

	$ACEx^{TM}$	FAST®	ISOPLANAR™	Power247™	SuperFET™
	ActiveArray™	FASTr™	LittleFET™	PowerSaver™	SuperSOT™-3
	Bottomless™	FPS™	$MICROCOUPLER^{TM}$	PowerTrench®	SuperSOT™-6
	CoolFET™	FRFET™	MicroFET™	QFET®	SuperSOT™-8
	$CROSSVOLT^{\text{TM}}$	GlobalOptoisolator™	MicroPak™	QS^{TM}	SyncFET™
	DOME™	GTO™ .	MICROWIRE™	QT Optoelectronics™	TinyLogic [®]
	EcoSPARK™	HiSeC™	MSXTM	Quiet Series™	TINYOPTO™
	E ² CMOS TM	I ² C TM	MSXPro™	RapidConfigure™	TruTranslation™
	EnSigna™	<i>i-</i> Lo [™]	OCX^{TM}	RapidConnect™	UHC™
	FACT™	ImpliedDisconnect™	OCXPro™	μSerDes™	UltraFET®
	FACT Quiet Serie	es [™]	OPTOLOGIC®	SILENT SWITCHER®	VCX TM
Across the board. Around the world.™		OPTOPLANAR™	SMART START™		
	The Power France		PACMAN™	SPM TM	
				<u> </u>	

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

POPTM

LIFE SUPPORT POLICY

 $Programmable \ Active \ Droop^{\tiny\mathsf{TM}}$

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- 1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the
- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

Stealth™

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition		
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.		
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.		
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.		
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.		

Rev. I11